

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/688,019	SPIES ET AL.	
Examiner	Shin-Hon Chen	Art Unit 2131	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
380	277-279	5/25/2006	S.C.
713	156,175	5/25/2006	S.C.
726	3	5/25/2006	S.C.